

Notice of References Cited	Application/Control No. 10/735,227	Applicant(s)/Patent Under Reexamination MITCHELL ET AL.	
	Examiner Raeann Gorden	Art Unit 3711	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,772,523	06-1998	Sheftic, Ted	473/227
	B	US-5,470,073	11-1995	Vasquez, Jose C.	473/206
	C	US-5,320,354	06-1994	Vasquez, Jose C.	473/213
	D	US-6,110,054	08-2000	Rodarte, Michael R.	473/203
	E	US-6,533,676	03-2003	D'Angelo et al.	473/239
	F	US-5,465,971	11-1995	Tischler, Edward A.	473/227
	G	US-5,976,024 A	11-1999	Marshall, Jr., Roger Lawrence	473/227
	H	US-6,398,663 B1	06-2002	Lin, Teh-Cheng	473/220
	I	US-5,904,624 A	05-1999	Martinez, Morris P.	473/212
	J	US-6,004,221 A	12-1999	Thornhill, Reginald L.	473/227
	K	US-3,951,416	04-1976	Koch et al.	473/212
	L	US-6,656,056 B1	12-2003	Leonard, Christopher	473/227
	M	US-5,865,685 A	02-1999	Thomas, Joseph G.	473/213

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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